China OPTO-EDU

CE, Rohs

A63.7081

5~20 Days

5000 pcs/ Month

1 pc

## 6x~1000000x Scanning Optical Microscope Digital Five Axis Motorized Stage

FOB \$1~1000, Depend on Order Quantity Carton Packing, For Export Transportation

### **Basic Information**

- Place of Origin:
- Brand Name:
- Certification:
- Model Number:
- Minimum Order Quantity:
- Price:
- Packaging Details:
- Delivery Time:
- Payment Terms: T/T, West Union, Paypal
- Supply Ability:



### **Product Specification**

- Resolution:
- Magnification:Electron Gun:

• Vacuum System:

• Highlight:

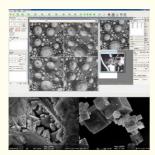
Schottky Electron Gun 6x~1000000x

0~30KV

- Schottky Emission Electron Gun
- Accelerating Voltage:
- Max Specimen Diameter: 320mm
  - Ion Pump, Turbo Molecular Pump Rotation Pump, Getter Pum
    - 6x scanning optical microscope, five axis scanning optical microscope

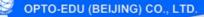


### More Images





6x~1000000x With Detector SED+CCD, Five Axes Motorized Stage E-Beam Acceleration With Stable Beam Current Supply Excellent Image Under Low Voltage Non Conduction Sample Can Be Observed Directly No Need To Be Sputtered In Low Voltage Easy & Friendly Operation Interface, All Controled By Mouse In Windows System Large Sample Room With Five Axes Eucentric Motorized Stage Large Size, Max Specimen Dia.340mm

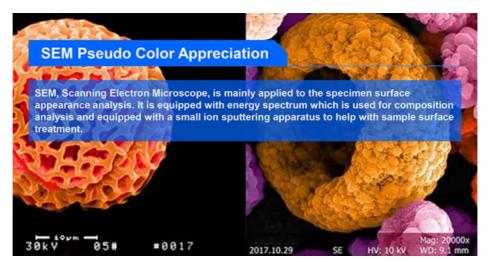


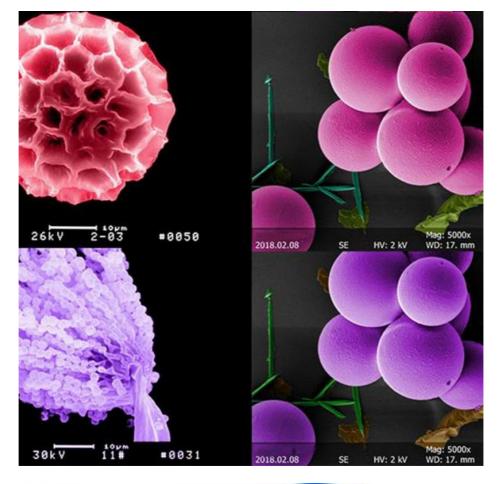
F-1501 Wanda Plaza, No.18 Shijingshan Road, Beijing 100043, China Tel:+8610 88696020 Fax:+8610 88696085

# A63.7081

# Schottky Field Emission Gun Scanning Electron Microscope Pro FEG SEM, 6x~1000000x

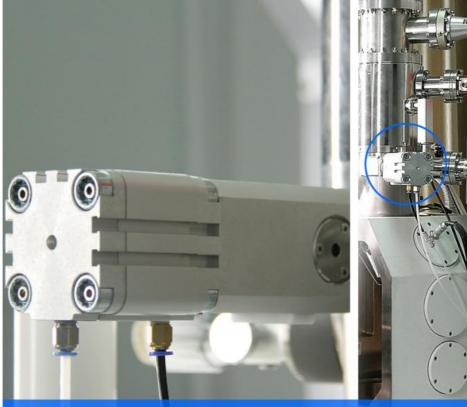












The Isolating Valve Ensures That The Upper Vacuum Is Not Affected When The Sample Room Is Opened



3 Molybdenum Objective Apertures, Adjustable Outside Of Vacuum System, No Need Disassemble Objective To Change Aperture

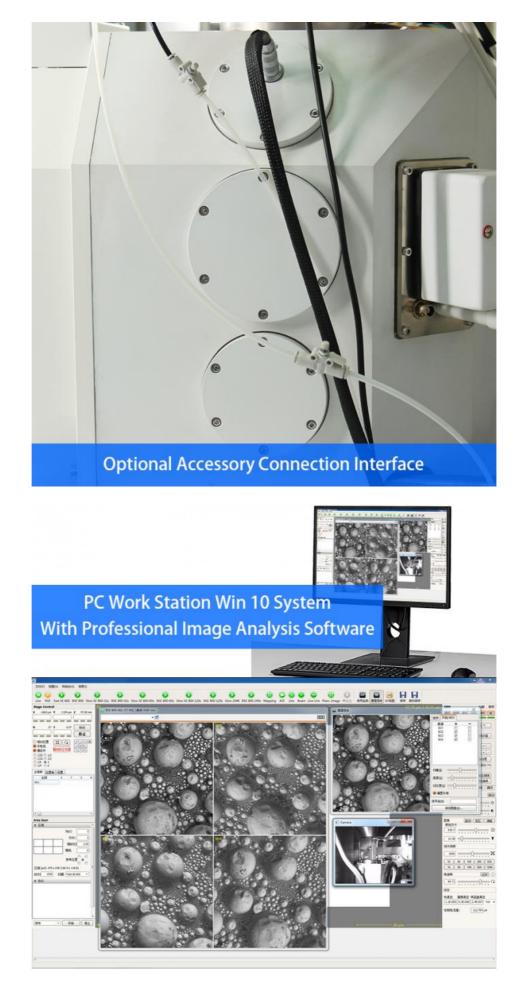




5 Axes Auto Middle Stage Touch Alert & Stop Function



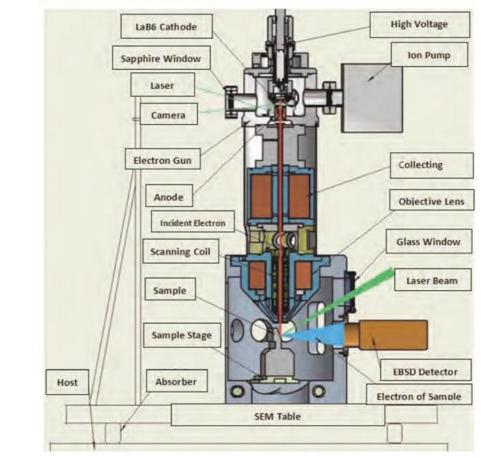
SE: High Vacuum Secondary Electron Detector (With Detector Protection)



A63.7080, A63.7081 Software Main Function			
High voltage integrated commissioning	Automatic filament on / off	Potential shift regulation	
Brightness adjustment	Electric to central adjustment	Automatic brightness	
Contrast adjustment	Objective lens adjustment	Auto focus	
Magnification adjustment	Objective degaussing	Automatic astigmatism elimination	

Selected area scanning mode	Electric rotation adjustment	Management of microscope parameters
Point scanning mode	Electron beam displacement adjustment	Real time display of scanning field size
Line scanning mode	Electron beam tilt adjustment	Gun lens adjustment
Surface scanning	Scanning speed adjustment	Multichannel input
High voltage power monitoring	Swing centering	Ruler measurement

# Working Principle



SEM	A63.7069	A63.7080	A63.7081
Resolution	3nm@30KV(SE)	1.5nm@30KV(SE)	1.0nm@30KV(SE)
	6nm@30KV(BSE)	3nm@30KV(BSE)	3.0nm@1KV(SE)
			2.5nm@30KV(BSE)
<b>A</b> agnification	8x~300000x Negative True Magnification	8x~800000x Negative True Magnification	6x~1000000x Negative True Magnification
Electron Gun	Pre-Centered Tungsten Filament	Schottky Field Emission Gun	Schottky Field Emission Gun
	Cartridge		
/oltage	Accelerating Voltage 0~30KV, Continuous	s Adjustable, Adjust Step 100V@0-10Kv, 1KV	/@10-30KV
Quick View	One Key Quick View Image Function	N/A	N/A
Lens System	Three-levels Electromagnetic Tapered	Multi-levels Electromagnetic Tapered Lens	-
	Lens		
Aperture	3 Molybdenum Objective Apertures, Adjustable Outside Of Vacuum System, No Need Disassemble Objective To Change Aperture		
/acuum	1 Turbo Molecular Pump	1 Ion Pump Set	1 Sputter Ion Pump
System	1 Mechanical Pump	1 Turbo Molecular Pump	1 Getter Ion Compound Pump
-,	Sample Room Vacuum>2.6E-3Pa	1 Mechanical Pump	1 Turbo Molecular Pump
	Electron Gun Room Vacuum>2.6E-3Pa	Sample Room Vacuum>6E-4Pa	1 Mechanical Pump
	Fully Auto Vacuum Control	Electron Gun Room Vacuum>2E-7 Pa	Sample Room Vacuum>6E-4Pa
	Vacuum Interlock Function	Fully Auto Vacuum Control	Electron Gun Room Vacuum>2E-7 Pa
		Vacuum Interlock Function	Fully Auto Vacuum Control
	Optional Model: A63.7069-LV		Vacuum Interlock Function
	1 Turbo Molecular Pump		
	2 Mechanical Pumps		
	Sample Room Vacuum>2.6E-3Pa		
	Electron Gun Room Vacuum>2.6E-3Pa		
	Fully Auto Vacuum Control		
	Vacuum Interlock Function		
	Low Vacuum Range 10~270Pa For		
	Quick Switch in 90 Seconds For		
	BSE(LV)		
Detector	SE: High Vacuum Secondary Electron	SE: High Vacuum Secondary Electron	SE: High Vacuum Secondary Electron
	Detector (With Detector Protection)	Detector (With Detector Protection)	Detector (With Detector Protection)

1	BSE: Semiconductor 4 Segmentation	Optional	Optional
	Back Scattering Detector	Optional	Optional
	Back Scallening Delector		
	Optional Model: A63.7069-LV		
	BSE(LV): Semiconductor 4		
	Segmentation		
	Back Scattering Detector		
	CCD: Infrared CCD Camera	CCD: Infrared CCD Camera	CCD: Infrared CCD Camera
Extend Port	2 Extend Ports On Sample Room For	4 Extend Ports On Sample Room For	4 Extend Ports On Sample Room For
	EDS, BSD, WDS etc.	BSE, EDS, BSD, WDS etc.	BSE, EDS, BSD, WDS etc.
Specimen	5 Axes Stage, 4 Auto +1 Manual Control	5 Axes Auto Middle Stage	5 Axes Auto Large Stage
Stage	Travel Range:	Travel Range:	Travel Range:
-	X=70mm, Y=50mm, Z=45mm,	X=80mm, Y=50mm, Z=30mm,	X=150mm, Y=150mm, Z=60mm,
	R=360°, T=-5°~+90°(Manual)	R=360°, T=-5°~+70°	R=360°, T=-5°~+70°
	Touch Alert & Stop Function	Touch Alert & Stop Function	Touch Alert & Stop Function
		Optional Model:	
		A63.7080-M 5 Axes Manual Stage	
		A63.7080-L 5 Axes Auto Large Stage	
Max Specimen	Dia.175mm, Height 35mm	Dia.175mm, Height 20mm	Dia.340mm, Height 50mm
Image System	Real Still Image Max Resolution	Real Still Image Max Resolution	Real Still Image Max Resolution
	4096x4096 Pixels,	16384x16384 Pixels,	16384x16384 Pixels,
	Image File Format: BMP(Default), GIF,	Image File Format: TIF(Default), BMP, GIF,	Image File Format: TIF(Default), BMP, GIF,
	JPG, PNG, TIF	JPG, PNG	JPG, PNG
		Video: Auto Record Digital .AVI Video	Video: Auto Record Digital .AVI Video
Computer &	PC Work Station Win 10 System, With Pro	ofessional Image Analysis Software To Fully C	Control Whole SEM Microscope Operation,
Software	Computer Specification No Less Than Inte	er I5 3.2GHz, 4G Memory, 24" IPS LCD Monit	or, 500G Hard Disk, Mouse, Keyboard
Photo Display	The Image Level Is Rich And Meticulous, Showing Real Time Magnification, Ruler, Voltage, Gray Curve		
Dimension	Microscope Body 800x800x1850mm	Microscope Body 800x800x1480mm	Microscope Body 1000x1000x1730mm
& Weight	Working Table 1340x850x740mm	Working Table 1340x850x740mm	Working Table 1330x850x740mm
	Total Weight 400Kg	Total Weight 450Kg	Total Weight 550Kg
		Optional Accessories	
Optional	A50.7002 EDS Energy Dispersive X-Ray	A50.7001 BSE Back Scattering Electron	A50.7001 BSE Back Scattering Electron
Accessories	Spectrometer	Detector	Detector
	A50.7011 Ion Sputtering Coater	A50.7002 EDS Energy Dispersive X-Ray	A50.7002 EDS Energy Dispersive X-Ray
		Spectrometer	Spectrometer
		A50.7011 Ion Sputtering Coater	A50.7011 Ion Sputtering Coater
		A50.7030 Motorize Control Panel	A50.7030 Motorize Control Panel

### **Product Accessories**





A50.7001 BSE Detector

A50.7002 EDS (X Ray Detector)



A50.7003 EBSD (Electron Beam Backscattered Diffraction)



A50.7013 Critical Point Dryer





A50.7011 Ion Sputtering Coater



A50.7012 Argon Ion Sputtering Coater



A50.7014 Electron Beam Lithography



A50.7030 Motorize Control Panel Motorize Control Panel, Integrated Computer Mouse To Control Magnification, Brightness, Contrast, Focus, Working Stage Moving Easily.

A50.7001	BSE Detector	Semiconductor Four Segment Back Scattering Detector; Available In Ingredients A+B, Morphology Info A-B; Available Sample Observe Without Sputtering Gold; Available In Observe Impurity And Distribution From Grayscale Map Directly.	
A50.7002	EDS (X Ray Detector)	Silicon Nitride (Si3N4) Window To Optimize Low Energy X-ray Transmission For Light Element Analysis; Excellent Resolution And Their Advanced Low-noise Electronics Provide Outstanding Throughput Performance; The Small Footprint Offers Flexibility To Ensure Ideal Geometry And Aata Collection Conditions; The Detectors Contain A 30mm2 Chip.	
A50.7003	EBSD (Electron Beam Backscattered Diffraction)	user could analysis crystal orientation, crystal phase and micro texture of materials and related materials performance,etc. automatic optimization of EBSD camera settings during the data collection, do interactive real-time analysis to obtain maximum information all the data were branded with time tag, which can be viewed at any time high resolution 1392 x 1040 x 12 Scanning and index speed: 198 points / sec, with Ni as the standard, under the condition of 2~5nA, it can ensure the index rate ≥99%; works well under the condition of low beam current and low voltage of 5kV at 100pA orientation measuring accuracy: Better than 0.1 degrees Using triplex index system: no need rely on single band definition , easy indexing of poor pattern quality dedicated database: EBSD special database obtained by electron diffraction: >400 phase structure Index ability: it can automatically index all crystal materials of 7 crystal systems. The advanced options include calculating elastic stiffness (Elastic Stiffness), Taylor (Taylor) factor, Schmidt (Schmid) factor and so on.	
A50.7010	Coating Machine	Glass Protecting Shell: ∮ 250mm; 340mm High; Glass Processing Chamber: ∮ 88mm; 140mm High, ∮ 88mm; 57mm High; Specimen Stage Size: ∮ 40mm (max); Vacuum System:molecula Pump And Mechanical Pump; Vacuum Detection: Pirani Gage; Vacuum:better Than 2 X 10-3 Pa; Vacuum Protection:20 Pa With Microscale Inflation Valve; Specimen Movement: Plane Rotation,tilt Precession.	
A50.7011	Ion Sputtering Coater	Glass Processing Chamber: ∮ 100mm; 130mm High; Specimen Stage Size: ∮ 40mm( Hold 6 Specimen Cups) ; Golden Target Size: ∮ 58mm*0.12mm(thickness); Vacuum Detection: Pirani Gage; Vacuum Protection:20 Pa With Microscale Inflation Valve; Medium Gas:argon Or Air With Argon Gas Special Air Inlet And Gas Regulating In Microscale.	
A50.7012	Argon Ion Sputtering Coater	The Sample Was Plated With Carbon And Gold Under High Vacuum; Rotatable Sample Table, Uniform Coating, Particle Size About 3-5nm; No Selection Of Target Material, No Damage To Samples; The Functions Of Ion Cleaning And Ion Thinning Can Be Realized.	
A50.7013	Critical Point Dryer	Inner Diameter: 82mm, Inner Length: 82mm; Pressure Range:0-2000psi; Temperature Range:0°-50° C (32°-122° F)	
A50.7014	Electron Beam Lithography	Based On Scanning Electron Microscope, A Novel Nano-exposure System Was Developed; The Modificaton Has Kept All The Sem Functions For Making Nanoscale Line Width Image; The Modificated Ebl System Widly Applied Into Microelectronic Devices, Optoelectronic Devices, Quantun Devices, Microelectronics System R&d.	





	A63.7080, A63	3.7081 Standard Consumables Outfit	
1	Field Emission Filament	Installed In Microscope	1 Pc
2	Sample Cup	Dia.13mm	5 Pcs
3	Sample Cup	Dia.32mm	5 Pcs
4	Carbon Double-sided Conductive Tape	6mm	1 Package
5	Vacuum Grease		10 Pcs
6	Hairless Cloth		1 Tube
7	Polishing Paste		1 Pc
8	Sample Box		2 Bags
9	Cotton Swab		1 Pc
10	Oil Mist Filter		1 Pc
	A63.7080, A63	3.7081 Standard Tools & Parts Outfit	
1	Inner Hexagon Spanner	1.5mm~10mm	1 Set
2	Tweezers	Length 100-120mm	1 Pc
3	Slotted Screwdriver	2*50mm, 2*125mm	2 Pcs
4	Cross Screwdriver	2*125mmm	1 Pc
5	Clean vent pipe	Dia.10/6.5mm(Out Diameter/Inner Diameter)	5m
6	Vent pressure reducing valve	Output Pressure 0-0.6MPa	1 Pc
7	Internal baking power supply	0-3A DC	2 Pcs
8	UPS power supply	10kVA	2 Pcs

### Working Condition, Requirement For Installation

#### 1. Applications:

SEM is mainly applied to the specimen surface appearance analysis. It is equipped with energy spectrum which is used for composition analysis and equipped with a small ion sputtering apparatus to help with sample surface treatment.

#### 2. Power Supply Requirements:

2.1 Voltage: AC 220V ± 10%, 50Hz ± 1 Hz, standard sine wave.

2.2 It is not recommended to share the power supply line with the instrument for equipment with high power and large power consumption change.

- 2.3 Three power sockets needed for:
  - 1. Scanning electron microscope instrument body, computer: AC 220V, 50Hz, 16A
  - 2. Mechanical pump and air compressor: AC 220V, 50Hz, 16A

#### 3. Environmental Requirements For Installation Site:

- 3.1 It is recommended to keep the temperature between 16~30 C
- 3.2 The relative humidity shall be less than 60%
- 3.3 Recommend configuration: air conditioner, dehumidifier and other equipment that can ensure
- the temperature and humidity of the laboratory.
- 3.4 Noise: < 68 DB

3.5 The durability of the instrument operation: continuously working

#### 4. A63.7081 Instrument Dimension & Weight

Microscope Body 1000x1000x1730mm Working Table 1330x850x740mm Total Weight 550Kg The floor bearing capacity should ≥ 250kg/m3, and it is recommended to place it on the first floor

#### 5. A63.7081 Packaging Dimension & Weight

1 Set in 3 Wooden Boxes: 110\*110\*158(cm) \*1 127\*115\*136(cm) \*1 160\*80\*111 (cm) \*1 Total Volume 5.3189CBM, Total G.W. 872 kg

After-sale Service

--Standard 1 Year Warranty Included

- --Extend Warranty 1 Year Cost 12% of Sales Contrast Amount
- --On-Site Installation Cost USD6000.0 For 5+2 Days
- --On-Site Maintenance Cost USD4500.0 For 3+2 Days

--Free Training for Visiting Customer in Beijing Included (Round Trip Ticket & Lodging Fee Not Included)

--Consumables Items & Accessories Available For All Life Time of Machine

